

Notice of References Cited		Application/Control No. 10/530,953	Applicant(s)/Patent Under Reexamination TAN ET AL.	
		Examiner Franklin S. Andramuno	Art Unit 2623	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0103076	06-2003	Neuman, Michael	345/723
*	C	US-5,898,695	04-1999	Fujii et al.	370/464
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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